

LOOKING AT SLOW AXONAL TRANSPORT

Stephen W. Carmichael and W. Stephen Brimijoin,¹ Mayo Clinic

Neurons are about as polarized as cells ever get. Their axonal process can extend a distance that is up to a million times the diameter of the nerve cell body. Axons have none of the ribosomal machinery responsible for protein synthesis, so all neuronal proteins and peptides must be manufactured near the nucleus and carried out to the periphery. This distribution involves at least two distinct mechanisms, fast axonal transport, moving at almost 500 mm per day, and slow axonal transport, moving only 0.1 to 3 mm per day. It turns out that proteins of the neuronal cytoskeleton, along with many soluble cytosolic proteins, are transported exclusively by the slower process. A long-standing unresolved question concerns the physical state in which cytoskeletal proteins are transported. Until recently it has not been known whether the axonal neurofilaments are assembled in the cell body and transported as intact structures, or whether their simple protein subunits are carried down the axon for assembly at or near the final destinations. Now a report¹ by Sumio Terada, Takao Nakata, Alan Peterson and Nobutaka Hirokawa, from the University of Tokyo and McGill University, definitively answers one part of this interesting question.

Clever methods and microscopic techniques provided the key to the answer. First, Terada and colleagues constructed a recombinant adenoviral vector encoding a specific, midsize neurofilament protein (NFM) tagged with a c-myc epitope. The selected protein could not form polymers by itself, so any transport along axons that lacked native neurofilaments would prove that subunits could be transported as such. NFM viral vector was used to infect sensory neurons, without damage, in dorsal root ganglia of transgenic mice. Most axons in these mice were completely free of neurofilaments, which precipitated in the cell body before exiting to the periphery. Epifluorescent microscopy showed that the exogenous NFM was incorporated into a characteristic neurofilamentous array in the

sensory ganglia, as in normal mice. Furthermore, immunoelectron microscopy demonstrated that the protein co-assembled with endogenous neurofilaments in the nerve cell bodies. These results showed that the recombinant protein was functionally similar to native NFM. The question was whether excess subunits of recombinant NFM would move into sensory axons.

To answer that question, Terada *et al.* examined peripheral nerve about one week after ganglionic infection. Recombinant NFM protein was revealed by immunocytochemistry with a monoclonal antibody to the c-myc epitope, using a confocal laser scanning microscope. As expected, the protein could still be localized in the infected cell bodies, but some of it had also been transported into the peripheral axons. The front tip of transported NFM appeared to be displaced distally at about 1 mm/day, squarely in the range for "slow axonal transport." Interestingly, there were signs of synchronous NFM transport in different axons. These and other results were consistent with an active transport mechanism, rather than mere passive diffusion. The evidence is thus convincing that at least one neurofilament protein can be transported as monomers or small oligomers, even in the absence of neurofilaments.

The study of Terada *et al.* represents a breakthrough in neurofilament biology. Considered with other studies, the results support the theory that neurofilament components can be propelled by members of the kinesin superfamily, acting as "motors", along microtubules, acting as "rails". Terada *et al.* consider the slow axonal transport system to be a kind of default pathway. Though it remains to be explained why the average speed in this pathway is so slow, the new findings are a major step forward in addressing one of the general problems of cell biology: How do cytosolic proteins and components of the neuronal cytoskeleton reach their appropriate destinations?

- 1 The authors gratefully acknowledge Professor Nobutaka Hirokawa for reviewing this article.
2. Terada, S., T. Nakata, A.C. Peterson, and N. Hirokawa, Visualization of slow axonal transport in viro, *Science* 273;784-788, 1996.

Front Page Image

ULTRA HIGH RESOLUTION STEM IMAGE OF SI BOUNDARY

Z-contrast image of a 39° symmetric tilt boundary in silicon ($S = 9 \{221\} < 110 > Si$) as viewed along the [110] direction, showing the periodic array of perfect edge dislocations. Images taken with the VG Microscope HB603U, 300 kV STEM at Oak Ridge National Laboratory (courtesy of M.F. Chesholm and S.J. Pennycook). For further information on this subject, refer to the article "The Analytical Limits: HADF (High Angle Dark Field Imaging)" by Dr. Michael Kersker of JEOL USA on page 14 of this publication.

MICROSCOPY TODAY

A monthly newsletter dedicated to the unique interests in microscopy of, and mailed at no cost to, some 8,000 microscopists worldwide.

PO Box 620122, Middleton, WI 53562 - Tel.: (608)836-1970 - Fax: (608)836-1969 - eMail: MicroToday@aol.com

<http://www.microscopy-today.com>

Copyright in 1996 by Today Enterprises. All rights reserved.

Don Grimes, Editor

Launch Your Field Emission SEM Capabilities To The 4nm At 1kV Level.

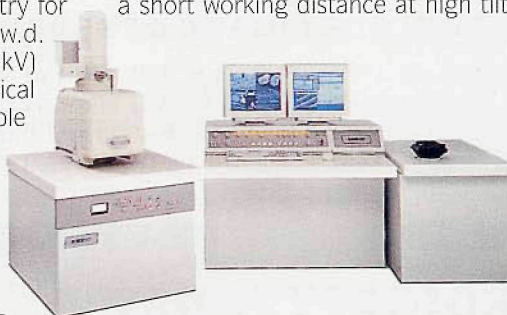
Published online by Cambridge University Press

The Amray Model 3600 LEAP

(Low Energy Advanced Performance) can propel your field emission SEM performance beyond current boundaries to a new standard of excellence. The Amray 3600 LEAP delivers:

- high resolution – 4nm at 1kV, 1.5nm at 15kV
- optimized geometry for a short working distance at high tilts with large samples (6mm w.d. at 45° tilt)
- high kV (25kV) for uncompromised analytical capabilities
- highly reliable patented Schottky field emission gun
- 2048 x 2048 frame buffer for advanced digital imaging
- two 17" high resolution, 1000 line viewing monitors
- 5 axes motorized eucentric stage
- motorized 8" linear load lock for rapid sample exchange
- embedded computer control for all SEM functions

The Amray 3600 LEAP provides resolution that's out of this world – call 1-800-225-1462 for complete information on the Model 3600 LEAP and other Amray systems.



AMRAY

160 Middlesex Tpke., Bedford, MA 01730 Tel: 617-275-1400 Fax: 617-275-0740

Circle Reader Inquiry #12

**Microscopy Society of America
Certification Program**

The Certification Program of the Microscopy Society of America (MSA) has been in existence for over 16 years. The purpose of the MSA Certification Program is to provide a means of assuring employers that holders of the certificate possess an acceptable level of technical skill in biological electron microscopy. Such a credential may be useful for job classification, for establishing salary level or potential for advancement, for personal goals and possibly for future use in applying for new positions. MSA provides the only certification of biological electron microscopy technologists in the United States, Central and South America, although similar programs exist in Europe and in Canada. Certification is not for everyone, since the process is both labor and time intensive and currently covers only biological electron microscopy. (The board is looking into the certification of non-biologists).

A written examination, administered two times a year (December and June), and proctored by an MSA member in the candidates' vicinity, is graded by the Certification Board. This exam consists of one hundred objective items covering: instrumentation, tissue processing, sectioning and staining, special techniques as well as photography, general chemistry, safety and history. A syllabus and reading list is provided in the application packet and the minimum passing score is 70%. One is permitted two attempts at this exam over a one year period. After a third failure, one must reapply anew.

The Certification Office has been contacted in the past by several state civil service boards about the procedures involved in certification of EMT's and some action at the state level for certification of technologists is anticipated in the near future.

For more information, telephone MSA at (800)538-3672 or check the WWW at:
<http://www.msa.microscopy.com>

The WINTER WORKSHOP on "ATOMIC STRUCTURE OF INTERFACES" will be held during January 8-11, 1997 at Arizona State University. This international gathering of experts, posdocs, and students will present and discuss new methods and results for atomic scale structure and chemistry analysis and synthesis of grain and interphase boundaries. Electron and field ion imaging, nanospectroscopies, diffraction, and scanning probe microscopy instrumentation, methods, and data analysis will be emphasized. For more information contact Mrs. Sharon Willison at (802)965-4424, Fax: (602)965-9004, eMail: sharon.willison@asu.edu

The 16th SOUTHERN BIOMEDICAL ENGINEERING CONFERENCE, jointly sponsored by Mississippi State University and the University of Mississippi Medical Center, will be held on April 4-6 1997 at the Broadwater Beach Resort and Hotel, Biloxi, MS.

Papers are being solicited on new developments in theory, concepts, applications and techniques in ALL facets of biomedical engineering. Attendance and professional program paper presentations by individuals from the USA and the entire world are encouraged and welcomed.

The hotel, located directly on the beautiful Gulf of Mexico, offers to its guests, golfing, tennis, and swimming facilities. For full meeting, registration and hotel information, visit: <http://abe.msstate.edu/abenews/bumgard.htm>

ICMAS Inc.

Sales Representatives in the Southeast for instrumentation and analytical lab services - representing:

**AMT - MVA - DIGITAL INSTRUMENTS -
Oxford/Link/Microspec - RMC - VBS - XEI**

During the year we hold free user oriented workshops.

Upcoming Workshops
Low Vac EDX - DEC

Call or mail for details: Tel: (423)984-8058
ICMAS Inc. Fax: (423)977-6719
1012 Hitch Road email: bhirche@usit.net
Maryville, TN 37804 <http://www.usit.net/icmas/>

NORAN/Tracor Northern EDS Repair

Factory and field trained personnel with over 35 years total experience, located in the Midwest, specializing in TN2000 and TN5500 repair, detector upgrades, data storage, imaging hardware and peripheral output devices - and used equipment resale.

Choose from a full maintenance or parts only contract, or on-demand service - at rates normally a fraction of others. Now accepting Visa, MC, AE and Purchasing cards.

For further information, contact Doug Connors at:

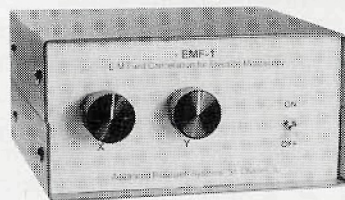
TN Analyzer Service

7897 Highway 19, Dane, WI 53529
Tel.: (608)798-2005 • Fax: (608)798-1675
eMail: Doug_TNAS@MSN.COM

EMF-1

**E-M field cancellation for
scanning electron microscopy**

\$495!



Small, portable device is...

- *inexpensive
- *effective
- *simple to install
- *easy to use
- *completely safe to use
- *a good diagnostic tool

If you use a scanning electron microscope, chances are that your work is limited by the electro-magnetic fields present in your lab. It is usually impractical to reduce the sources of those fields. But now you can cancel them out - directly at the specimen chamber where they affect your work, without creating additional large scale fields.

Advanced Research Systems, 317 North 4th. Street, St. Charles, IL 60174
PH 630.513.7093 FAX 630.513.7092 email info@sem.com